

<b>Notice of References Cited</b>	Application/Control No. 10/761,926	Applicant(s)/Patent Under Reexamination ZAWADA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	N				Haas et al.	C02F 1/50
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**NON-PATENT DOCUMENTS**

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